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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : John V. Frangioni et al.   Art Unit   : 3737
Appln. No.: 10/772,425   Examiner : Not yet assigned
Filed   : February 6, 2004
Title   : MATERIALS AND METHODS FOR NEAR-INFRARED AND INFRARED
              LYMPH NODE MAPPING

United States Patent and Trademark Office
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Randolph Building
401 Dulany Street
Alexandria, VA 22314

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

As a means of complying with the duty of disclosure under 37 CFR §1.56, and in accordance with 37 CFR §§1.97 and 1.98, Applicants, through the undersigned attorney, submit this Supplemental Information Disclosure Statement along with the attached form PTO-1449. Applicants also submit a copy of the International Search Report.
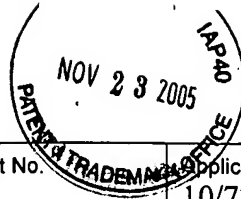
No fees are believed to be due. Please apply any charges or credits to Deposit Account No. 19-4293.

Respectfully submitted,

Date: 11-23-05

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14952.0319	Application No. 10/772,425

Information Disclosure Statement by Applicant
(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant		
John V. Frangioni et al.		
Filing Date February 6, 2004	Group Art Unit 3737	

U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
		5,101,827	04/07/1992	Goldenberg			
		6,633,370	10/14/2003	Lawandy			
		6,819,692	11/16/2004	Klimov et al.			
		6,444,192	09/03/2002	Mattrey			

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes	No

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document

Examiner Signature	Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.